

(Use several sheets if necessary)

07150.00281

2-16-01

FILING

**September 28, 2000**

GROUP.

2829

WC841 U.S. PRO  
09/676292

## FOREIGN PATENT DOCUMENTS

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)

**EXAMINER**

Evon Pert

DATE CONSIDERED

9/30/03

**Form PTO-A820**  
**(also form PTO-1449)**

# 2 2-16-01

**INFORMATION DISCLOSURE CITATION**

(Use several sheets if necessary)

ATTY DOCKET NO.

07150.003001

SERIAL NO.

Fredrick W. CRIST et al

FILING

September 28, 2000

GROUP

2829

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

**FOREIGN PATENT DOCUMENTS**

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)

EP	A3	Schlumberger Publication, SABER Connectivity Solutions Service Description, Version 1.2, dated April 26, 2000, 16 pages
EP	A4	Schlumberger Specification Sheet, "IDS 10000da, E-Beam probe system for IC design analysis", dated 9/99, 2 pages

EXAMINER

Evan R +

DATE CONSIDERED

9/30/03

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

# INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

ATTY DOCKET NO.

07150.003001

SERIAL NO.

Fredrick W. CRIST et al

FILING

September 28, 2000

GROUP

2829

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

21	A5	Schlumberger Specification Sheet," ITS 9000KX, The industry's most accurate VLSI test system for highest yields and throughput", dated 7/99, 2 pages

EXAMINER

Evan Per +

DATE CONSIDERED

9/30/03

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

#3

# INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

APR 29 2002

PATENT & TRADEMARK OFFICE

Docket Number (Optional)

07150/003001

Application Number

09/676,292

Applicant(s)

Fredrick W. Crist, et al

Filing Date

09/28/2000

Group Art Unit

2133 2829

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
EP	A1	6,236,952 B1	5/22/2001	Jun, et al	702	119	6/30/98

COPY OF PAPERS  
ORIGINALLY FILED

RECEIVED

MAY 02 2002

Technology Center 2100

## FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EP	A2	M. Bertocco, F. Ferraris, C. Offelli, M. Parvis, "A Client Server Architecture for Distributed Measurement Systems" IEEE Instrumentation and Measurement Technology Conference, May 18-21, 1998 pgs 67-72
EP	A3	F. Algeria and H.G. Ramos, "A Remote Controlled Automated Measurement System" IEEE Instrumentation and Measurement Technology Conference, May 19-21, 1997, 2 pages

EXAMINER

Evan Pert

DATE CONSIDERED

9-30-03

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

INFORMATION (Us 82)  
APR 29 2002  
PATENT & TRADEMARK OFFICE